

**Search Notes**

Application/Control No.

10/521,260

Examiner

Jason M. Perilla

Applicant(s)/Patent under  
Reexamination

PAYNE ET AL.

Art Unit

2611

**SEARCHED**

Class	Subclass	Date	Examiner
375	316	3/9/2007	JP
	317	3/9/2007	JP
	334	3/9/2007	JP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East USPAT/USPGPUB EPO/JPO	3/9/2007	JP
Inventor Name Search EAST/EDAN	3/9/2007	JP